DESCRIPTION

TITLE OF THE INVENTION

DEFECT LOCATION ESTIMATION SYSTEM, METHOD OF ESTIMATING DEFECT LOCATION, AND NON-TRANSITORY STORAGE MEDIUM

~~DEFECTIVE SITE INFERENCE SYSTEM, DEFECTIVE SITE INFERENCE METHOD, AND PROGRAM~~

FIELD OF THE INVENTION

[0001] The present disclosure relates to a defect location estimation system, a method of estimating defect location, and a program.

BACKGROUND OF THE INVENTION

[0002] In refrigerating and air-conditioning systems that include refrigerating and air-conditioning equipment used for freezing, refrigeration, or air-conditioning, there is known technology that uses sensors to identify the position where a defect has occurred.

[0003] For example, there is known a refrigerant leakage detection system that includes a refrigerant leakage detection device that detects refrigerant leakage based on outputs of a plurality of refrigerant sensors, and a plurality of alarms, and displays an area or the like where refrigerant leakage has occurred on display means when refrigerant leakage has occurred (see, for example, Patent Document 1).

RELATED-ART DOCUMENT

Patent Documents

[0004]

[Patent Document 1] International Patent Publication WO2017/002215A1 ~~Japanese Patent Application Laid-Open No. 2017-525732~~